## Notice of References Cited Application/Control No. 10/624,511 Examiner Feben M. Haile Applicant(s)/Patent Under Reexamination CEREDA ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

	C.S. I ATEN DOCUMENTO					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2002/0050873	05-2002	Tsunoda et al.	333/132	
	В	US-				
	С	US-				
	D	US-				
	E	US-				
	F	US-				
	G	US-				
	Н	US-				
	ı	US-				
	J	US-	_			
	К	US-				
	L	US-				
	М	US-				

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## NON-PATENT DOCUMENTS

	NON I ALENT DOCUMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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